

Search Notes

Application/Control No.

10/798,047

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
709	220-226	7/5/2006	CBS
710	8-13	7/5/2006	CBS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	13		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	7/5/2006	CBS
PALM (DOUBLE PATENTING/INVENTOR)	7/5/2006	CBS
EAST (EPO, JPO, USPGPUB, USPAT, DERWENT, IBMTDB, USOCR)	7/5/2006	CBS